

<b>Notice of References Cited</b>	Application/Control No. 10/656,777	Applicant(s)/Patent Under Reexamination YU ET AL.	
	Examiner Jason M. Han	Art Unit 2875	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,826,294	05-1989	Imoto, Satoshi	349/67
	B	US-2002/0044437	04-2002	Lee, Joung Jae	362/31
	C	US-2002/0113924	08-2002	Saito et al.	349/112
	D	US-6,561,663	05-2003	Adachi et al.	362/616
	E	US-2004/0012971	01-2004	Tsai et al.	362/390
	F	US-6,700,554	03-2004	Ham et al.	345/75.2
	G	US-6,734,926	05-2004	Fan et al.	349/58
	H	US-6,747,404	06-2004	Rha, Sa Kyun	313/491
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP05119313A	05-1993	Japan	Morita	F21V 7/12
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.